The 63rd





Dr. Peng Wang

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Title: Energy Filtered Scanning Confocal Electron Microscopy

The current experimental implementations of an energy filtered scanning confocal electron microscope (EFSCEM) using a microscope fitted with two spherical aberration correctors will be reported, a method for establishing EFSCEM electron trajectories will be described and by collecting inelastically scattered electrons with a characteristic energy-loss we show that three-dimensional chemical mapping at the nanoscale can be performed.

Chair: Dr. Takeguchi, Advanced Nano Characterization Center, NIMS

Venue:

8th Floor

Room #811, Central bldg., SENGEN Site

Date: February 1st, Monday Time: 2:00-2:45 pm

Contact: International Center for Young Scientists (ICYS), Nakajima (ext 6075)